SDLS108 - APRIL 1985 - REVISED MARCH 1988

- Package Options Include Plastic "Small Outline" Packages, Ceramic Chip Carriers and Flat Packages in Addition to Plastic and Ceramic DIPs
- Dependable Texas Instruments Quality and Reliability

description

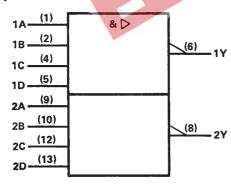
These devices contain two independent 4-input NAND buffer gates.

The SN5440, SN54LS40, and SN54S40 are characterized for operation over the full military temperature range of -55°C to 125°C. The SN7440, SN74LS40, and SN74S40 are characterized for operation from 0°C to 70°C.

FUNCTION TABLE (each gate)

	INP	UTS		OUTPUT
A	В	С	D	Y
Н	Н	Н	н	L
L	X	X	x	Н
Х	L	X	x	н
Х	Х	L	X	Н
Х	X	Х	L	Н

logic symbol†



[†]This symbol is in accordance with ANSI/IEEE Std. 91-1984 and IEC Publication 617-12.

Pin numbers shown are for D, J, N, and W packages.

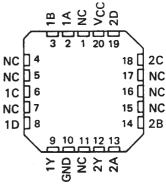
SN5440 . . . J PACKAGE SN54LS40, SN54S40 . . . J OR W PACKAGE SN7440 . . . N PACKAGE SN74LS40, SN74S40 . . . D OR N PACKAGE (TOP VIEW)

1A 🗆	1	U14 VCC
1B 🗀	2	13 2D
NC 🗆	3	12 2C
1C 🗆	4	11 NC
1D 🗆	5	10 2B
1Y 🗀	6	9 2A
GND 🗀	7	8 2Y
1B C NC C 1C C 1D C 1Y C	3 4 5	13 2D 12 2C 11 NC 10 2B 9 2A

SN5440 . . . W PACKAGE (TOP VIEW)

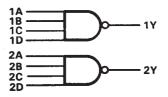


SN54LS40, SN54S40 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

logic diagram



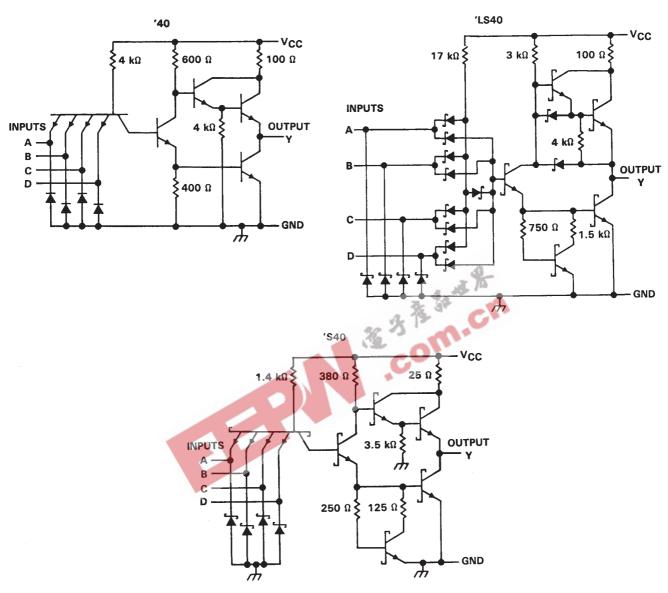
positive logic

 $Y = \overline{A \cdot B \cdot C \cdot D}$ or $Y = \overline{A} + \overline{B} + \overline{C} + \overline{D}$



1

schematics (each gate)



Resistor values shown are nominal.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, VCC (see Note 1)	7 V
nout voltage: '40. 'S40	5.5 V
′LS40	7 V
Operating free-air temperature range: SN54'	25°C
SN74'	70°C
Storage temperature range65°C to 15	

NOTE 1: Voltage values are with respect to network ground terminal.



SN5440, SN54LS40, SN54S40 SN7440, SN74LS40, SN74S40 DUAL 4-INPUT POSITIVE-NAND BUFFERS SDLS108 – APRIL 1985 – REVISED MARCH 1988

recommended operating conditions

			SN5440)		SN7440)	UNIT
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Vcc	Supply voltage	4.5	5	5.5	4.75	5	5.25	٧
VIH	High-level input voltage	2			2			V
VIL	Low-level input voltage			0.8			0.8	V
ЮН	High-level output current			- 1.2			- 1.2	mA
loL	Low-level output current			48			48	mA
TA	Operating free-air temperature	- 55		125	0		70	°c

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDIT	uone t			SN5440)		SN7440)	UNIT
FARAMETER	i	LEST COMPLI	TONS		MIN	TYP‡	MAX	MIN	TYP‡	MAX	DIVIT
VIK	V _{CC} = MIN,	I _I = - 12 mA					- 1.5			- 1.5	V
Voн	V _{CC} = MIN,	V _{1L} = 0.8 V,	I _{OH} = - 1.2 mA		2.4	3.3		2.4	3.3		V
VoL	V _{CC} = MIN,	V _{IH} = 2 V,	I _{OL} = 48 mA			0.2	0.4		0.2	0.4	V
١ _١	V _{CC} = MAX,	V _I = 5.5 V					1			1	mA
ЧН	V _{CC} = MAX,	V ₁ = 2.4 V					40			40	μА
IL	V _{CC} = MAX,	V _I = 0.4 V				- B	– 1.6			– 1.6	mA
los§	V _{CC} = MAX				- 20	E/A	- 70	- 18		– 70	mA
ГССН	V _{CC} = MAX,	V ₁ = 0		38	7.3	4	8		4	8	mA
ICCL	V _{CC} = MAX,	V ₁ = 4.5 V		1 19	, 4	17	27	ĺ	17	27	mA

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$ (see note 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)		TEST CO	NDITIONS	MIN	TYP	MAX	UNIT
^t PLH	Any	V		$R_1 = 133 \Omega$,	C _I = 15 pF		13	22	กร
t _{PHL}	Any			nL = 133 12,	CL - 15 pr		8	15	ns

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.



[‡] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$. § Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed 100 milliseconds.

SN5440, SN54LS40, SN54S40 SN7440, SN74LS40, SN74S40 DUAL 4-INPUT POSITIVE-NAND BUFFERS SDLS108 – APRIL 1985 – REVISED MARCH 1988

recommended operating conditions

	S	N54LS	40	S	N74LS4	10	UNIT
	MIN	NOM	MAX	MIN	NOM	MAX 5.25 0 8 - 1.2 24 70	ONT
V _{CC} Supply voltage	4.5	5	5.5	4.75	5	5.25	٧
VIH High-level input voltage	2			2			V
VIL Low-level input voltage			0.7		_	0 8	V
IOH High-level output current		******	- 1.2			– 1.2	mA
IOL Low-level output current			12			24	mA
TA Operating free-air temperature	- 55		125	0		70	°c

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

					S	N54LS4	10	S	N74LS4	10	UNIT
PARAMETER		TEST CONDIT	TONS T		MIN	TYP ‡	MAX	MIN	TYP‡	MAX	UNIT
ViK	V _{CC} = MIN,	I _I = - 18 mA					- 1.5			– 1.5	٧
V _{OH}	V _{CC} = MIN,	VIL = MAX,	I _{OH} = - 1.2 mA		2.5	3.4		2.7	3.4		٧
.,	V _{CC} = MIN,	V _{IH} = 2 V,	I _{OL} = 12 mA	<u> </u>		0.25	0.4		0.25	0.4	v
VOL	V _{CC} = MIN,	V _{IH} = 2 V,	IOL = 24 mA						0.35	0.5	
I ₁	V _{CC} = MAX,	V _I = 7 V					0.1			0.1	mA
Чн	V _{CC} = MAX,	V _I = 2.7 V					20			20	μΑ
ΙΙŁ	V _{CC} = MAX,	V _I = 0.4 V				- A	0.4			- 0.4	mA
IOS§	V _{CC} = MAX				-30	4	- 130	- 30		– 130	mA
Іссн	V _{CC} = MAX,	V ₁ = 0		B	19	0.45	711		0.45	1_	mA
CCL	V _{CC} = MAX,	V ₁ = 4.5 V		- K.		3	6		3	6	mA

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$ (see note 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
tPLH			$R_1 = 667 \Omega$, $C_1 = 45 pF$		12	24	ns
tPHL	Any		$R_{\perp} = 667 \Omega$, $C_{\perp} = 45 pF$		12	24	ns

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.



[‡] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$. § Not more than one output should be shorted at a time, and the duration of the short circuit should not exceed one second.

SN5440, SN54LS40, SN54S40 SN7440, SN74LS40, SN74S40 DUAL 4-INPUT POSITIVE-NAND BUFFERS SDLS108 – APRIL 1985 – REVISED MARCH 1988

recommended operating conditions

			SN54S4	0		SN74S4	0	UNIT
		MIN	NOM	MAX	MIN	NOM	MAX 5.25 0.8 - 3 60	UNIT
Vcc	Supply voltage	4.5	5	5.5	4.75	5	5.25	٧
VIH	High-level input voltage	2			2			٧
VIL	Low-level input voltage			0.8			0.8	V
Іон	High-level output current			- 3			- 3	mA
IOL.	Low-level output current			60			60	mA
TA	Operating free-air temperature	- 55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

					S	N54S40)		N74S40)	UNIT
PARAMETER		TEST CONDIT	IONS I		MIN	TYP ‡	MAX	MIN	TYP‡	MAX	UNIT
VIK	V _{CC} = MIN,	I ₁ = - 18 mA					- 1.2			- 1.2	٧
Voн	V _{CC} = MIN,	V _{1L} = 0.8 V,	1 _{OH} = - 3 mA		2.5	3.4		2.7	3.4		٧
VOL	V _{CC} = MIN,	V _{IH} = 2 V,	I _{OL} = 60 mA				0.5			0.5	٧
i _I	V _{CC} = MAX,	V _I = 5.5 V					1			1	mA
ЧН	V _{CC} = MAX,	V _I = 2.7 V					0.1			0.1	mA
¹ 1L	V _{CC} = MAX,	V _I = 0.5 V				4	- 4			- 4	mA
los§	V _{CC} = MAX				- 50	[/h	– 225	- 50		- 225	mA
1ссн	V _{CC} = MAX,	V _I = 0		- de	34	10	18		10	18	mA
ICCL	V _{CC} = MAX,	V ₁ = 4.5 V		12 19	P	25	44		25	44	mA

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$ (see note 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CON	IDITIONS	MIN TYP	MAX	UNIT
t _{PLH}			R _L = 93 Ω,	C _L = 50 pF	4	6.5	ns
t _{PHL}	Any		n 93 14,	C[- 50 pr	4	6.5	ns
^t PLH	Any		$R_L = 93 \Omega$,	C _L = 150 pF	6		ns
^t PHL			NL - 55 12,		6		ns

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.



[‡] All typical values are at V_{CC} = 5 V, T_A = 25°C. § Not more than one output should be shorted at a time, and the duration of the short-circuit should not exceed 100 milliseconds.

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